# **Bunch Length Measurements Using Beam Position Monitors (BPMs)** C. Richard, Michigan State University, East Lansing, MI, USA S. Cogan, S. Lidia, Facility for Rare Isotope Beams, East Lansing, MI, USA

## Signals Measured by BPMs

- Broad band signals measured using time interleaved sampling
- 40.25 MHz signal is sampled at 119 MHz
- Results in an effective sampling rate of 2.737 GHz



## Simulations

- CST Studio simulations confirm the analytic field distribution at the pipe wall
  - Simulated pencil beam and uniform beam distributions for different offsets, beam sizes, and velocities
  - Measured field at points on wall and with a BPM model



- The signals need to be calibrated for effects from the digitizer, 500 MHz low pass filtering, and dispersion from the cables connecting the pick ups to the digitizer
- Harmonics of 80.5 MHz were input into the cables for each button on a BPM and measured with the digitizer
- The signals must also be corrected for the impedance of the buttons



- The calibrated signals represent the field distribution measured by the buttons, not the bunch distribution
- For a transversely and longitudinally longitudinal bunch the field on the pipe wall is •

$$\sigma_{\text{wall}}(\omega, z_m, \phi_m) = D_{\omega} \cos\left[\frac{\omega}{\beta c}(z_m - z_0)\right] \int dA_{\text{beam}} \sum_{n=0} \frac{I_n(gr/R_p)}{\pi N I_n(g)} \cos[n(\phi_m - \phi)] e^{-\frac{(x - x_0)^2}{2\sigma_x^2} - \frac{(y - y_0)^2}{2\sigma_y^2}} \qquad g = \frac{\omega R_p}{\gamma \beta c},$$
  
J. Cuperous, NIM, 1977

The round button geometry is accounted for with a transit time factor

#### FRIB MEBT Measurements

Fit the field equation with TTF to measured signals using seven fit parameters • Fit parameters: amplitude, noise offset,  $x_0$ ,  $y_0$ ,  $\sigma_x$ ,  $\sigma_y$ ,  $\sigma_z$ 



This factor is calculated for each azimuthal mode separately

$$\Gamma(\omega) = \frac{2}{n} \int_{-R_b}^{R_b} \mathrm{d}z_m \cos\left[\frac{\omega}{\beta c}(z_m - z_0)\right] \sin\left[\frac{n}{R_p}\sqrt{R_b^2 - z_0}\right]$$

## Scaling with Transverse Properties

- Scalings with g  $\bullet$ 
  - Need to account for transverse properties up to g~1
  - In FRIB MEBT, ß=0.032 corresponding to g~1-6 for measurable bandwidth ۲



## Button Sum Scaling

- Fitting the parameters needs improvements
  - The transverse position and beam size match measurements from the BPMs and wire  $\bullet$ profile scanner
  - Longitudinal beam size from fitting fails to follow trend of simulation when scanning the voltage of a buncher cavity



- By adding the button signals, the measurements are less dependent of the transverse distribution
  - Offsetting a pencil beam 1.5 mm deviates by ~6% from centered case. For a single  $\bullet$ button the deviation is  $\sim 50\%$
- But, the beam position and transverse sizes cannot be uniquely determined with this method



